

**Notice of References Cited**

Application/Control No.

09/606,897

Applicant(s)/Patent Under  
Reexamination  
LIN ET.AL.

Examiner

Aristotelis M Psitos

Art Unit

2653

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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Page **2** of **2****U.S. PATENT DOCUMENTS**

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